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Title:Backward wave radiation from negative permittivity waveguides and its use for THz subwavelength imaging

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Abstract:In this paper we demonstrate the possibility of backward radiation from a negative permittivity planar (slab) waveguide. Furthermore, we show that backward radiation can be used to achieve sub-wavelength imaging of a point source placed close to such a slab or to a periodic layered system of slabs. Finally, we demonstrate backward-radiation-based imaging in the case of realistic materials operating in the THz regime, such as polaritonic alkali-halide systems. ©2012 Optical Society of America.

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